

Sheet 1 of 1

Form PTO-1449 COMMERCE (REV. 7-80)		U.S. DEPARTMENT OF PATENT AND TRADEMARK OFFICE		Atty. Docket No. US 010570		Serial No. 09/988,946										
INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)				Applicant ANTONIO J. COLMENAREZ ET AL.												
				Filing Date 11/19/01		Group 2621 2623										
U.S. PATENT DOCUMENTS																
Ex. Int.		Document Number						Date	Name	Class	Sub- class	Filing Date If Approp.				
<i>Chc</i>	AA	6	2	6	3	0	8	8	7/17/01	CRABTREE ET AL.	382	103				
<i>Chc</i>	AB	5	5	4	8	6	6	1	8/20/96	PRICE ET AL.	382	133				
	AC															
	AD															
	AE															
	AF															
FOREIGN PATENT DOCUMENTS																
		Document Number						Date	Country	Class	Sub- class	Trans. Yes No				
<i>Chc</i>	AG	1	2	2	9	4	9	3	A	2	7/8/02	EUROPE	G06T	5/00	X	
	AH															
	AI															
	AJ															
	AK															
OTHER (Including Author, Title, Date, Pertinent Pages, Etc.)																
<i>Chc</i>	AL	Dempster et al: "Maximum Likelihood From Incomplete Data Via The EM Algorithm" Journal Of The Royal Statistical Society. Series B. Methodological, Royal statistical Society, London, GB, vol. 39, no. 1, 1977, pages 1-38														
	AM															
	AN															
Examiner <i>Chc</i>										Date Considered 2-4-05						
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include a copy of this form with next communication to applicant.																

RECEIVED

APR 07 2003

Technology Center 2600

Sheet 1 of 1Form PTO-1449 U.S. DEPARTMENT OF COMMERCE
(REV. 7-80) PATENT AND TRADEMARK OFFICE

Atty. Docket No.

US010570

Serial No.

09/988,946

INFORMATION DISCLOSURE CITATION
(Use several sheets if necessary)

ANTONIO COLMENAREZ

Filing Date

NOVEMBER 19, 2001

Group

2623
2621**RECEIVED**

SEP 12 2003

Technology Center 2600

U.S. PATENT DOCUMENTS

Ex. Int		Document Number	Date	Name	Class	Sub-class	Filing Date If Approp.
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Sub-class	Trans.	
							Yes	No
	AG							
	AH							
	AI							
	AJ							
	AK							

OTHER (Including Author, Title, Date, Pertinent Pages, Etc.)

AL	Dempster AP et al., "Maximum Likelihood from Incomplete Data Via the EM Algorithm", Journal of the Royal Statistical Society, Series B, Methodological, Royal Statistical Society, London, GB, vol. 39, no. 1, pp.1-38, XP009002229
AN	(already considered)
AN	— cur

Examiner

Date Considered

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with M 609; Draw line through citation if not in conformance and not considered. Include a copy of this form with next communication to applicant.